A5832

BiMOS II 32-Bit Serial Input Latched Driver

Discontinued Product
These parts are no longer in production The device should not be purchased for new design applications. Samples are no longer availabl
Date of status change: October 31, 2005
Recommended Substitutions:
For new customers or new applications, refer to the <u>A6832</u> .

NOTE: For detailed information on purchasing options, contact your local Allegro field applications engineer or sales representative.

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UCN5832A LOGIC SUPPLY 1 40 CLOCK V_{DD} SERIAL 2 39 SERIAL DATA OUT GROUND 3 38 OUTPUT ENABLE STROBE 4 -->> -36 OUT31 OUT₁ 5 - 35 OUT 30 OUT₂ 6 34 OUT 29 оит₃ [7 -D>-OUT4 8 33 OUT₂₈ −D>> 32 OUT₂₇ OUT₅ 9 LATCHES REGISTER REGISTER -1>> 31 OUT₂₆ OUT₆ 10 OUT7 11 - 29 OUT₂₄ OUT 8 12 OUT₉ 12 27 OUT 22 OUT₁₀ 14 - 26 OUT₂₁ OUT 11 1 - 25 OUT₂₀ OUT₁₂ 16 24 OUT 19 \sim OUT 13 17 23 OUT 18 OUT 14 18 \triangleright OUT 15 19 22 OUT₁₇ OUT 16 2 21 INTERNAL CONNECTION Dwg. No. A-12,377A **ABSOLUTE MAXIMUM RATINGS** at +25°C Free-Air Temperature Output Voltage, VOUT 40 V Logic Supply Voltage, V_{DD} 15 V Input Voltage Range, V_{IN}-0.3 V to V_{DD} + 0.3 V Continuous Output Current, I_{OUT} 150 mA Package Power Dissipation, P_D See Graph Operating Temperature Range, T_A -20°C to +85°C Storage Temperature Range,

Caution: CMOS devices have input-static protection but are susceptible to damage when exposed to extremely high static electrical charges.

Intended originally to drive thermal printheads, the UCN5832A and UCN5832EP have been optimized for low output-saturation voltage, high-speed operation, and pin configurations most convenient for the tight space requirements of high-resolution printheads. These integrated circuits can also be used to drive multiplexed LED displays or incandescent lamps at up to 150 mA peak current. The combination of bipolar and MOS technologies gives BiMOS II arrays an interface flexibility beyond the reach of standard buffers and power driver circuits.

The devices each have 32 bipolar NPN open-collector saturated drivers, a CMOS data latch for each of the drivers, two 16-bit CMOS shift registers, and CMOS control circuitry. The high-speed CMOS shift registers and latches allow operation with most microprocessor based systems. Use of these drivers with TTL may require input pull-up resistors to ensure an input logic high. MOS serial data outputs permit cascading for interface applications requiring additional drive lines.

The UCN5832A is supplied in a 40-pin dual in-line plastic package with 0.600" (15.24 mm) row spacing. Under normal operating conditions, this device will allow all outputs to sustain 100 mA continuously without derating. The UCN5832EP is supplied in a 44-lead plastic leaded chip carrier for minimum area, surface-mount applications. Both devices are also available for operation from -40°C to +85°C. To order, change the prefix from 'UCN' to 'UCQ'.

Similar 32-bit serial-input latched source drivers are available as the UCN5818AF/EPF. Other high-voltage, high-current 8-bit devices are available as the UCN5821A, UCN5841A/LW, and UCN5842A.

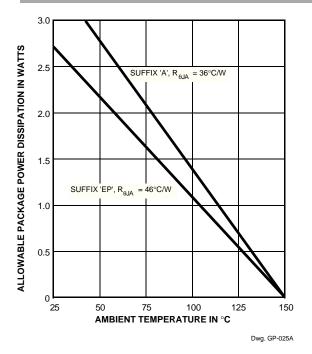
FEATURES

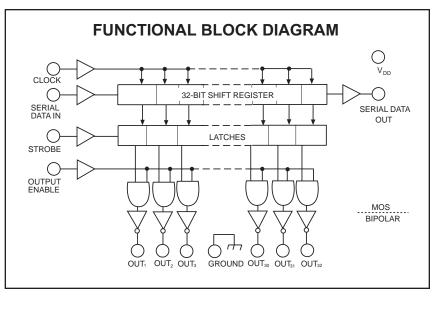
- To 3.3 MHz Data Input Rate
- Low-Power CMOS Logic and Latches
- 40 V Current Sink Outputs
- Low Saturation Voltage
- Automotive Capable

Always order by complete part number:

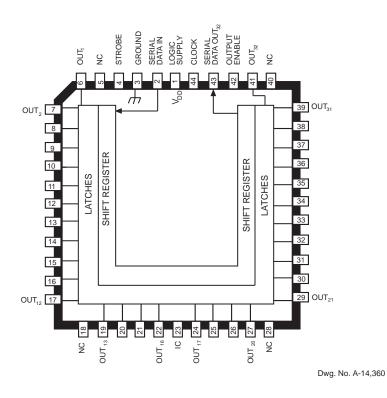
Part Number	Package
UCN5832A	40-Pin DIP
UCN5832EP	44-Lead PLCC







UCN5832EP





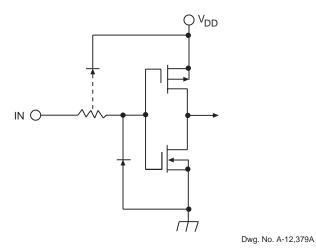
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ELECTRICAL CHARACTERISTICS at T_A = +25°C, V_{DD} = 5 V (unless otherwise noted).

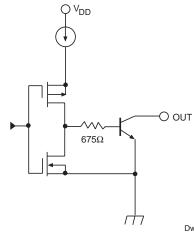
				Limits		
Characteristic	Symbol	Test Conditions	Min.	Max.	Units	
Output Leakage Current	I _{CEX}	$V_{OUT} = 40 \text{ V}, \text{ T}_{A} = 70^{\circ}\text{C}$	—	10	μΑ	
Collector-Emitter	V _{CE(SAT)}	I _{OUT} = 50 mA	—	275	mV	
Saturation Voltage		l _{OUT} = 100 mA, "A" package	150	550	mV	
		l _{OUT} = 100 mA, "EP" package	_	550	mV	
Input Voltage	V _{IN(1)}		3.5	5.3	V	
	V _{IN(0)}		-0.3	+0.8	V	
Input Current	I _{IN(1)}	V _{IN} = 3.5 V	—	1.0	μΑ	
	I _{IN(0)}	V _{IN} = 0.8 V	—	-1.0	μΑ	
Input Impedance	Z _{IN}	V _{IN} = 3.5 V	3.5	_	MΩ	
Serial Data Output Resistance	R _{out}		—	20	kΩ	
Supply Current	I _{DD}	One output ON, I _{OUT} = 100 mA	_	5.0	mA	
		All outputs OFF		50	μΑ	
Output Rise Time	t _r	l _{OUT} = 100 mA, 10% to 90%	_	1.0	μs	
Output Fall Time	t _f	l _{OUT} = 100 mA, 90% to 10%		1.0	μs	

NOTE: Positive (negative) current is defined as going into (coming out of) the specified device pin.

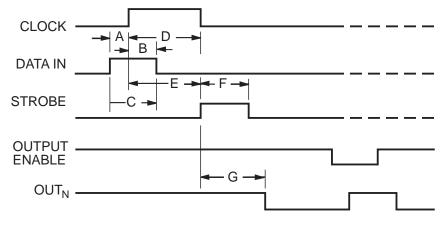
TYPICAL INPUT CIRCUIT



TYPICAL OUTPUT DRIVER



Dwg. No. A-12,380A



Dwg. No. A-12,276A

TIMING CONDITIONS

(V_{DD} = 5.0 V, Logic Levels are V_{DD} and Ground)

A. Minimum Data Active Time Before Clock Pulse (Data Set-Up Time)	75 ns
B. Minimum Data Active Time After Clock Pulse (Data Hold Time)	
C. Minimum Data Pulse Width	150 ns
D. Minimum Clock Pulse Width	150 ns
E. Minimum Time Between Clock Activation and Strobe	300 ns
F. Minimum Strobe Pulse Width	100 ns
G. Typical Time Between Strobe Activation and Output Transition	500 ns

Serial Data present at the input is transferred to the shift register on the logic "0" to logic "1" transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUTPUT. The SERIAL DATA must appear at the input prior to the rising edge of the CLOCK input waveform.

Information present at any register is transferred to its respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the OUTPUT ENABLE input be low during serial data entry.

When the OUTPUT ENABLE input is low, all of the output buffers are disabled (OFF) without affecting the information stored in the latches or shift register. With the OUTPUT ENABLE input high, the outputs are controlled by the state of the latches.

Serial		s	hift	Regi	ister	Cont	ents	Serial			Latch Contents			Output	Output Contents							
Data Input	Clock Input		I ₂	I ₃		I _{N-1}	I _N	Data Output	Strobe Input	I ₁	I ₂	I ₃		I _{N-1}	I _N	Enable Input	I ₁	l ₂	I ₃		I _{N-1}	I _N
Н	Г	н	R_1	R_2		R _{N-2}	R _{N-1}	R _{N-1}														
L	Г	L	R_1	R_2		R _{N-2}	R _{N-1}	R _{N-1}														
Х	1	R_1	R_2	R_3		R _{N-1}	R_N	R _N														
		Х	Х	Х		Х	Х	Х	L	R ₁	R_2	R_3		R _{N-1}	R_N							
		P ₁	P_2	P_3		P _{N-1}	P_{N}	P _N	Н	P ₁	P_2	P_3		P _{N-1}	P_N	Н	P ₁	P_2	P_3		P_{N-1}	P_{N}
										Х	Х	Х		Х	Х	L	Н	Н	Н		Н	Н

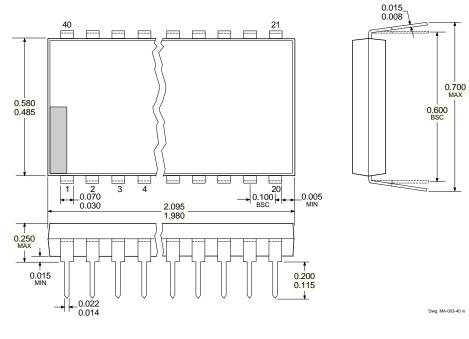
TRUTH TABLE

L = Low Logic Level H = High Logic Level X = Irrelevant P = Present State R = Previous State

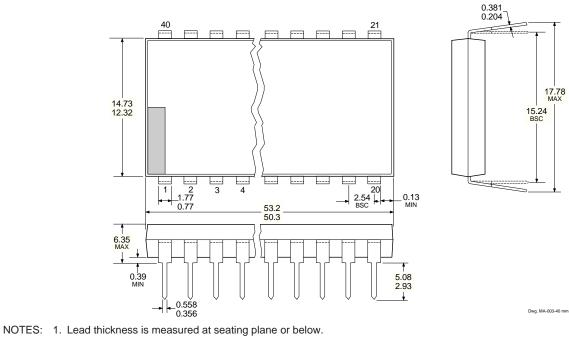


UCN5832A

Dimensions in Inches (controlling dimensions)

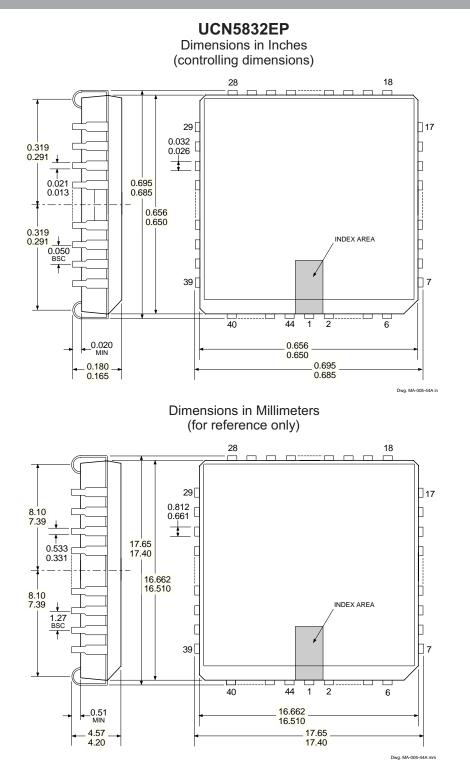


Dimensions in Millimeters (for reference only)



2. Lead spacing tolerance is non-cumulative.

3. Exact body and lead configuration at vendor's option within limits shown.



NOTES: 1. Exact body and lead configuration at vendor's option within limits shown. 2. Lead spacing tolerance is non-cumulative.



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BiMOS II (Series 5800) & DABiC IV (Series 6800) INTELLIGENT POWER INTERFACE DRIVERS SELECTION GUIDE

Function	Output F	Part Number †						
SERIAL-INPUT LATCHED DRIVERS								
8-Bit (saturated drivers)	-120 mA	50 V‡	5895					
8-Bit	350 mA	50 V	5821					
8-Bit	350 mA	80 V	5822					
8-Bit	350 mA	50 V‡	5841					
8-Bit	350 mA	80 V‡	5842					
9-Bit	1.6 A	50 V	5829					
10-Bit (active pull-downs)	-25 mA	60 V	5810-F and 6809/10					
12-Bit (active pull-downs)	-25 mA	60 V	5811 and 6811					
20-Bit (active pull-downs)	-25 mA 60 V 5812							
32-Bit (active pull-downs)	-25 mA	60 V	5818-F and 6818					
32-Bit	100 mA	30 V	5833					
32-Bit (saturated drivers)	100 mA	40 V	5832					
PARALL	EL-INPUT LATCHED D	RIVERS						
4-Bit	350 mA	50 V‡	5800					
8-Bit	-25 mA	60 V	5815					
8-Bit	350 mA	50 V‡	5801					
SPEC	CIAL-PURPOSE FUNCT	IONS						
Unipolar Stepper Motor Translator/Driver	1.25 A	50 V‡	5804					
Addressable 28-Line Decoder/Driver	450 mA	30 V	6817					

* Current is maximum specified test condition, voltage is maximum rating. See specification for sustaining voltage limits. Negative current is defined as coming out of (sourcing) the output.

† Complete part number includes additional characters to indicate operating temperature range and package style.

‡ Internal transient-suppression diodes included for inductive-load protection.

Allegro MicroSystems, Inc. reserves the right to make, from time to time, such departures from the detail specifications as may be required to permit improvements in the design of its products.

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